

Notice of References Cited

Application/Control No.

10/516,812

Applicant(s)/Patent Under
Reexamination
HOCEVAR ET AL.

Examiner

Gerald Gauthier

Art Unit

2614

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2002/0018445 A1	02-2002	Kobayashi, Toshihiko	370/241
*	B	US-2002/0061100 A1	05-2002	DiCamillo et al.	379/221.02
*	C	US-6,826,272 B1	11-2004	Dalrymple et al.	379/220.01
*	D	US-6,885,658 B1	04-2005	Ress et al.	370/352
*	E	US-6,937,598 B1	08-2005	Haghirahim et al.	370/356
*	F	US-6,977,911 B1	12-2005	Geen et al.	370/328
*	G	US-7,031,279 B2	04-2006	Lee et al.	370/331
*	H	US-7,043,749 B1	05-2006	Davies, Steven Gareth	725/120
*	I	US-7,272,135 B1	09-2007	Ohtsu et al.	370/356
*	J	US-2008/0059647 A1	03-2008	Jabri et al.	709/231
*	K	US-7,355,988 B1	04-2008	Denbar et al.	370/282
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
	W	
	X	

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